nexperia

Important notice

Dear Customer,

On 7 February 2017 the former NXP Standard Product business became a new company with the tradename **Nexperia**. Nexperia is an industry leading supplier of Discrete, Logic and PowerMOS semiconductors with its focus on the automotive, industrial, computing, consumer and wearable application markets

In data sheets and application notes which still contain NXP or Philips Semiconductors references, use the references to Nexperia, as shown below.

Instead of http://www.nxp.com, http://www.philips.com/ or http://www.semiconductors.philips.com/, use **http://www.nexperia.com**

Instead of sales.addresses@www.nxp.com or sales.addresses@www.semiconductors.philips.com, use **salesaddresses@nexperia.com** (email)

Replace the copyright notice at the bottom of each page or elsewhere in the document, depending on the version, as shown below:
- © NXP N.V. (year). All rights reserved or © Koninklijke Philips Electronics N.V. (year). All rights reserved
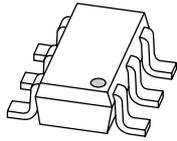Should be replaced with:
- **© Nexperia B.V. (year). All rights reserved**.

If you have any questions related to the data sheet, please contact our nearest sales office via e-mail or telephone (details via **salesaddresses@nexperia.com**). Thank you for your cooperation and understanding,

Kind regards,

Team Nexperia

1. Product profile

1.1 General description

PNP low V_{CEsat} Breakthrough in Small Signal (BISS) transistor and NPN Resistor-Equipped Transistor (RET) in a SOT457 (SC-74) small Surface Mounted Device (SMD) plastic package.

1.2 Features

■ Low V_{CEsat} (BISS) and resistor-equipped transistor in one package
■ Low threshold voltage (< 1 V) compared to MOSFET
■ Low drive power required
■ Space-saving solution
■ Reduction of component count

1.3 Applications

■ Supply line switches
■ Battery charger switches
■ High-side switches for LEDs, drivers and backlights
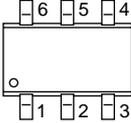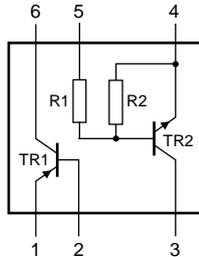■ Portable equipment

1.4 Quick reference data

Table 1:   Quick reference data

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
TR1; PNP low V_{CEsat} transistor						
V_{CEO}	collector-emitter voltage	open base	-	-	−20	V
I_C	collector current (DC)		-	-	−1	A
R_{CEsat}	collector-emitter saturation resistance	$I_C = -1$ A; $I_B = -100$ mA	[1] -	185	280	mΩ
TR2; NPN resistor-equipped transistor						
V_{CEO}	collector-emitter voltage	open base	-	-	50	V
I_O	output current		-	-	100	mA
R1	bias resistor 1 (input)		15.4	22	28.6	kΩ
R2/R1	bias resistor ratio		0.8	1	1.2	

[1]   Pulse test: $t_p \leq 300$ µs; $\delta \leq 0.02$.

2. Pinning information

Table 2:   Pinning

Pin	Description	Simplified outline	Symbol
1	emitter TR1		
2	base TR1		
3	output (collector) TR2		
4	GND (emitter) TR2		
5	input (base) TR2		
6	collector TR1		

3. Ordering information

Table 3:   Ordering information

Type number	Package			
	Name	Description		Version
PBLS2004D	SC-74	plastic surface mounted package; 6 leads		SOT457

4. Marking

Table 4:   Marking codes

Type number	Marking code
PBLS2004D	F9

5. Limiting values

Table 5:   Limiting values
*In accordance with the Absolute Maximum Rating System (IEC 60134).*

Symbol	Parameter	Conditions	Min	Max	Unit
TR1; PNP low V_{CEsat} transistor					
V_{CBO}	collector-base voltage	open emitter	-	−20	V
V_{CEO}	collector-emitter voltage	open base	-	−20	V
V_{EBO}	emitter-base voltage	open collector	-	−5	V
I_C	collector current (DC)		-	−1	A
I_{CM}	peak collector current	$t_p \leq 300$ µs	-	−2	A
I_B	base current (DC)		-	−0.3	A
I_{BM}	peak base current	$t_p \leq 300$ µs	-	−0.6	A
P_{tot}	total power dissipation	$T_{amb} \leq 25$ °C [1]	-	250	mW
		[2]	-	350	mW
		[3]	-	400	mW

Table 5:   Limiting values *…continued*

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
TR2; NPN resistor-equipped transistor						
V_{CBO}	collector-base voltage	open emitter		-	50	V
V_{CEO}	collector-emitter voltage	open base		-	50	V
V_{EBO}	emitter-base voltage	open collector		-	10	V
V_I	input voltage					
	positive			-	+40	V
	negative			-	−10	V
I_O	output current			-	100	mA
I_{CM}	peak collector current	$t_p \leq 300\ \mu s$		-	100	mA
P_{tot}	total power dissipation	$T_{amb} \leq 25\ °C$	[1]	-	200	mW
Per device						
P_{tot}	total power dissipation		[1]	-	400	mW
			[2]	-	530	mW
			[3]	-	600	mW
T_{stg}	storage temperature			−65	+150	°C
T_j	junction temperature			-	150	°C
T_{amb}	ambient temperature			−65	+150	°C

[1]   Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.

[2]   Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm^2.

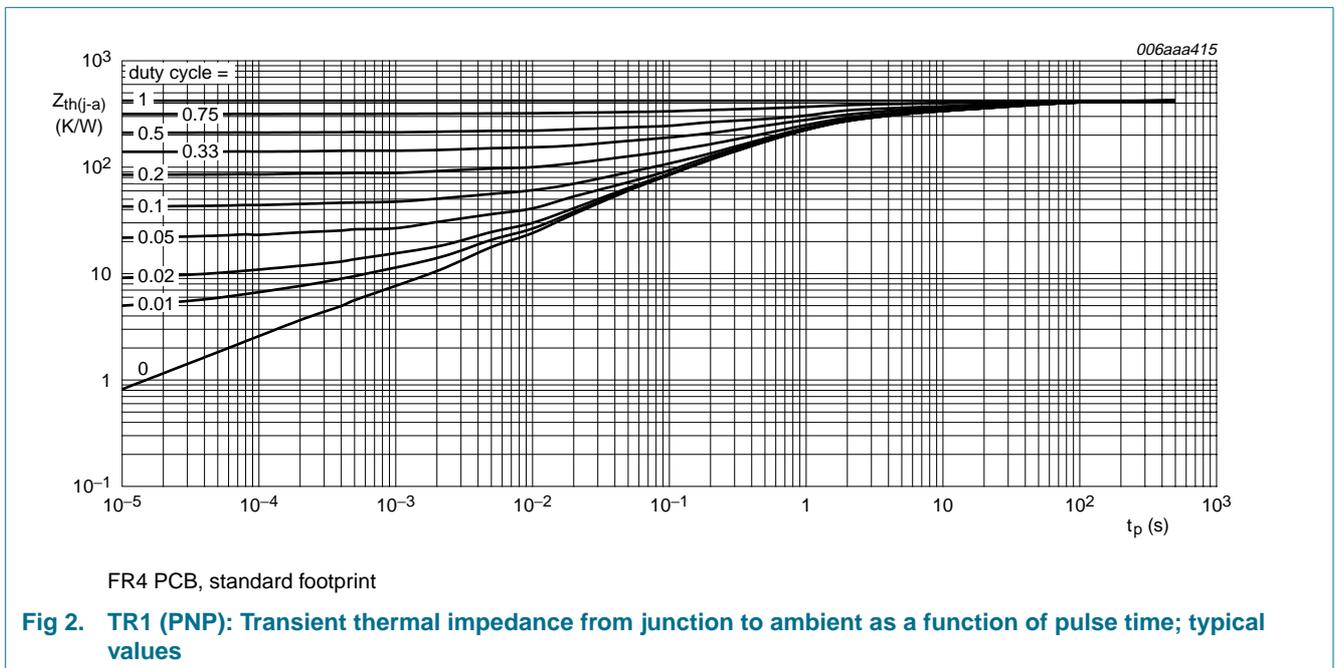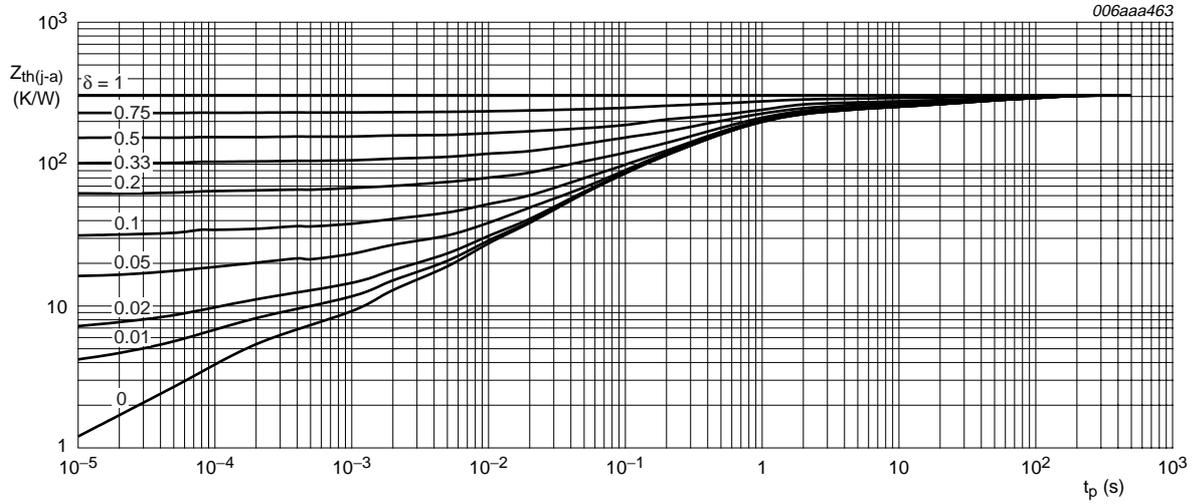[3]   Device mounted on a ceramic PCB, Al_2O_3, standard footprint.

(1)   Ceramic PCB, Al_2O_3, standard footprint

(2)   FR4 PCB, mounting pad for collector 1 cm^2

(3)   FR4 PCB, standard footprint

Fig 1.   Power derating curves
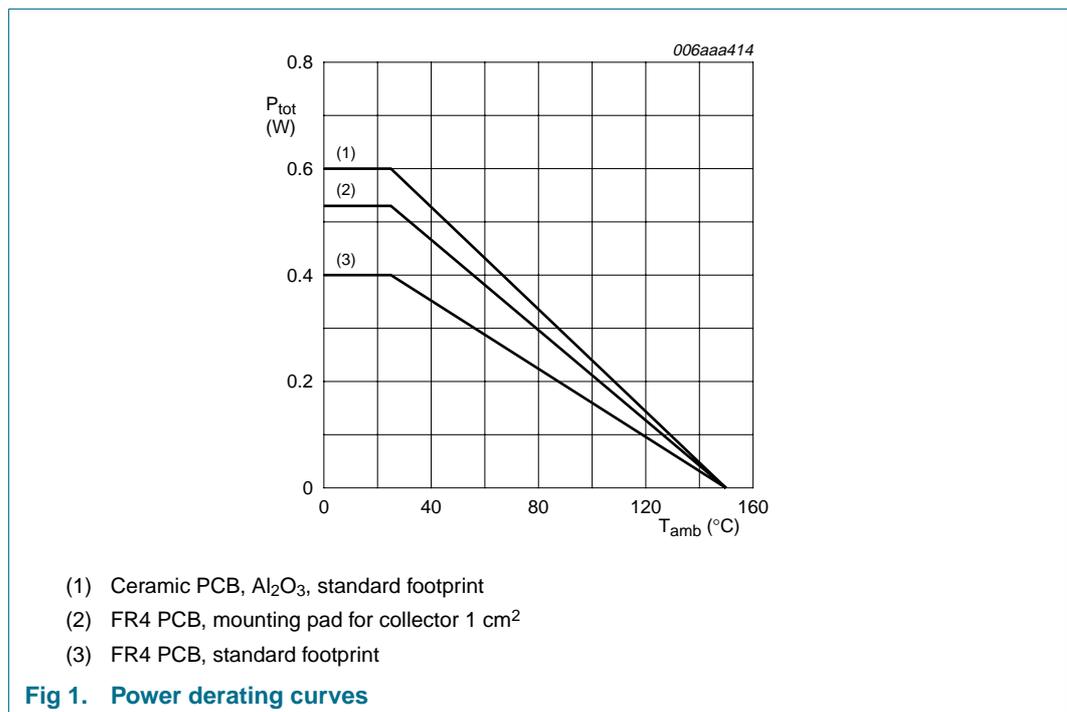
6. Thermal characteristics

Table 6: **Thermal characteristics**

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Per device						
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air	[1] -	-	315	K/W
			[2] -	-	236	K/W
			[3] -	-	210	K/W

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm^2.

[3] Device mounted on a ceramic PCB, Al$_2$O$_3$, standard footprint.

FR4 PCB, standard footprint

Fig 2. TR1 (PNP): Transient thermal impedance from junction to ambient as a function of pulse time; typical values

FR4 PCB, mounting pad for collector 1 cm^2

Fig 3. TR1 (PNP): Transient thermal impedance from junction to ambient as a function of pulse time; typical values
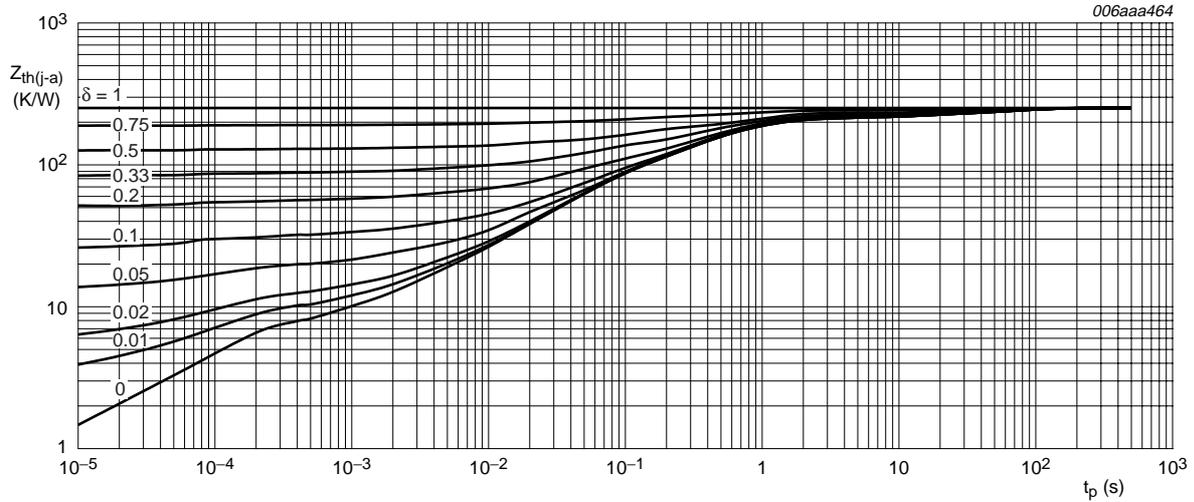
Ceramic PCB, Al$_2$O$_3$, standard footprint

Fig 4. TR1 (PNP): Transient thermal impedance from junction to ambient as a function of pulse time; typical values

7. Characteristics

Table 7:   Characteristics

T_{amb} = 25 °C unless otherwise specified.

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
TR1; PNP low V$_{CEsat}$ transistor							
I_{CBO}	collector-base cut-off current	V_{CB} = −20 V; I_E = 0 A		-	-	−0.1	µA
		V_{CB} = −20 V; I_E = 0 A; T_j = 150 °C		-	-	−50	µA
I_{CES}	collector-emitter cut-off current	V_{CE} = −20 V; V_{BE} = 0 V		-	-	−0.1	µA
I_{EBO}	emitter-base cut-off current	V_{EB} = −5 V; I_C = 0 A		-	-	−0.1	µA
h_{FE}	DC current gain	V_{CE} = −2 V; I_C = −1 mA		220	495	-	
		V_{CE} = −2 V; I_C = −100 mA		220	440	-	
		V_{CE} = −2 V; I_C = −500 mA	[1]	220	310	-	
		V_{CE} = −2 V; I_C = −1 A	[1]	155	220	-	
		V_{CE} = −2 V; I_C = −2 A	[1]	60	120	-	
V_{CEsat}	collector-emitter saturation voltage	I_C = −100 mA; I_B = −1 mA		-	−55	−90	mV
		I_C = −500 mA; I_B = −50 mA	[1]	-	−100	−150	mV
		I_C = −1 A; I_B = −50 mA	[1]	-	−200	−300	mV
		I_C = −1 A; I_B = −100 mA	[1]	-	−185	−280	mV
R_{CEsat}	collector-emitter saturation resistance	I_C = −1 A; I_B = −100 mA	[1]	-	185	280	mΩ
V_{BEsat}	base-emitter saturation voltage	I_C = −1 A; I_B = −50 mA	[1]	-	−0.95	−1.1	V
		I_C = −1 A; I_B = −100 mA	[1]	-	−1	−1.1	V
V_{BEon}	base-emitter turn-on voltage	V_{CE} = −5 V; I_C = −1 A	[1]	-	−0.85	−1.1	V
t_d	delay time	I_C = −1 A; I_{Bon} = −50 mA; I_{Boff} = 50 mA		-	8	-	ns
t_r	rise time			-	34	-	ns
t_{on}	turn-on time			-	42	-	ns
t_s	storage time			-	140	-	ns
t_f	fall time			-	45	-	ns
t_{off}	turn-off time			-	185	-	ns
f_T	transition frequency	I_C = −50 mA; V_{CE} = −10 V; f = 100 MHz		150	185	-	MHz
C_c	collector capacitance	V_{CB} = −10 V; I_E = i_e = 0 A; f = 1 MHz		-	15	20	pF

PBLS2004D_1

Product data sheet   **Rev. 01— 23 June 2005**   **6 of 16**

Table 7:   Characteristics …continued

$T_{amb} = 25\,^{\circ}C$ unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
TR2; NPN resistor-equipped transistor						
I_{CBO}	collector-base cut-off current	$V_{CB} = 50$ V; $I_E = 0$ A	-	-	100	nA
I_{CEO}	collector-emitter cut-off current	$V_{CE} = 30$ V; $I_B = 0$ A	-	-	1	µA
		$V_{CE} = 30$ V; $I_B = 0$ A; $T_j = 150\,^{\circ}C$	-	-	50	µA
I_{EBO}	emitter-base cut-off current	$V_{EB} = 5$ V; $I_C = 0$ A	-	-	180	µA
h_{FE}	DC current gain	$V_{CE} = 5$ V; $I_C = 5$ mA	60	-	-	
V_{CEsat}	collector-emitter saturation voltage	$I_C = 10$ mA; $I_B = 0.5$ mA	-	-	150	mV
$V_{I(off)}$	off-state input voltage	$V_{CE} = 5$ V; $I_C = 100$ µA	-	1.1	0.8	V
$V_{I(on)}$	on-state input voltage	$V_{CE} = 0.3$ V; $I_C = 5$ mA	2.5	1.7	-	V
R1	bias resistor 1 (input)		15.4	22	28.6	kΩ
R2/R1	bias resistor ratio		0.8	1	1.2	
C_c	collector capacitance	$V_{CB} = 10$ V; $I_E = i_e = 0$ A; $f = 1$ MHz	-	-	2.5	pF

[1]   Pulse test: $t_p \leq 300$ µs; $\delta \leq 0.02$.

006aaa416
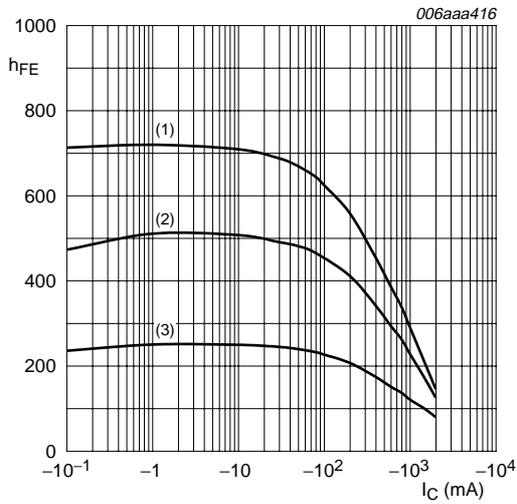
$V_{CE} = -2$ V

(1) $T_{amb} = 100$ °C

(2) $T_{amb} = 25$ °C

(3) $T_{amb} = -55$ °C

Fig 5. TR1 (PNP): DC current gain as a function of collector current; typical values

006aaa417
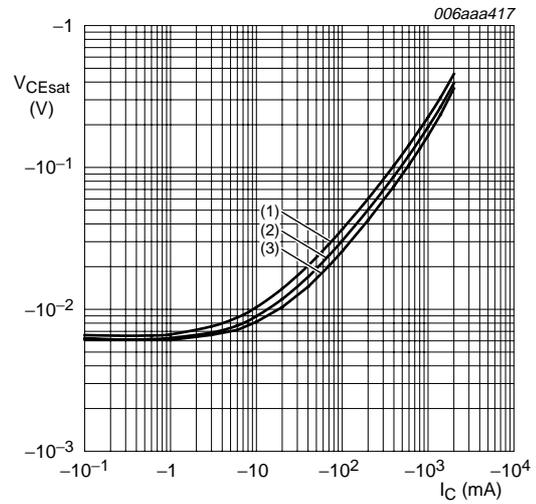
$I_C/I_B = 20$

(1) $T_{amb} = 100$ °C

(2) $T_{amb} = 25$ °C

(3) $T_{amb} = -55$ °C

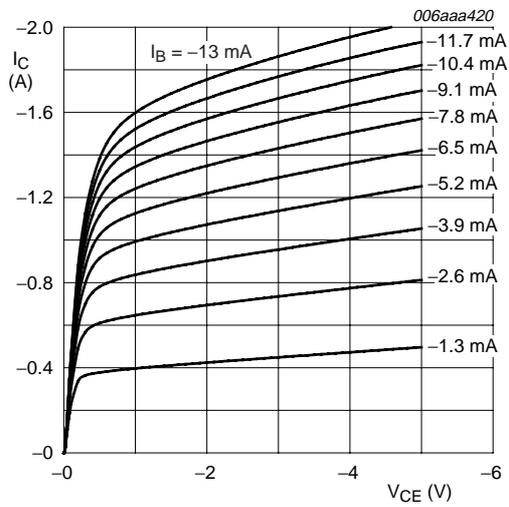**Fig 6. TR1 (PNP): Collector-emitter saturation voltage as a function of collector current; typical values**

006aaa418
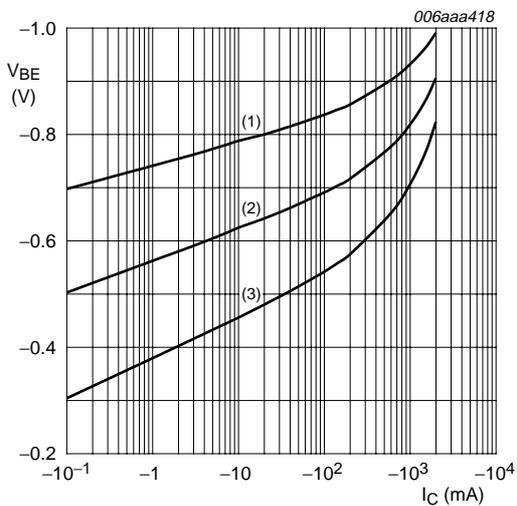
$V_{CE} = -5$ V

(1) $T_{amb} = -55$ °C

(2) $T_{amb} = 25$ °C

(3) $T_{amb} = 100$ °C

Fig 7. TR1 (PNP): Base-emitter voltage as a function of collector current; typical values

006aaa419
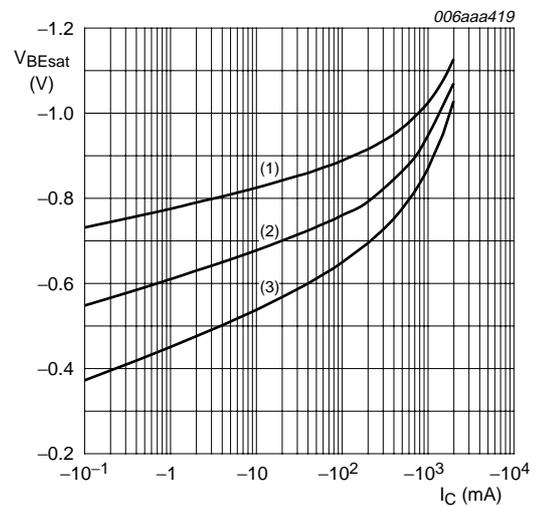
$I_C/I_B = 20$

(1) $T_{amb} = -55$ °C

(2) $T_{amb} = 25$ °C

(3) $T_{amb} = 100$ °C

Fig 8. TR1 (PNP): Base-emitter saturation voltage as a function of collector current; typical values

PBLS2004D_1

Product data sheet

Rev. 01 — 23 June 2005

8 of 16

006aaa420

$T_{amb} = 25\ °C$

Fig 9. TR1 (PNP): Collector current as a function of collector-emitter voltage; typical values

006aaa421
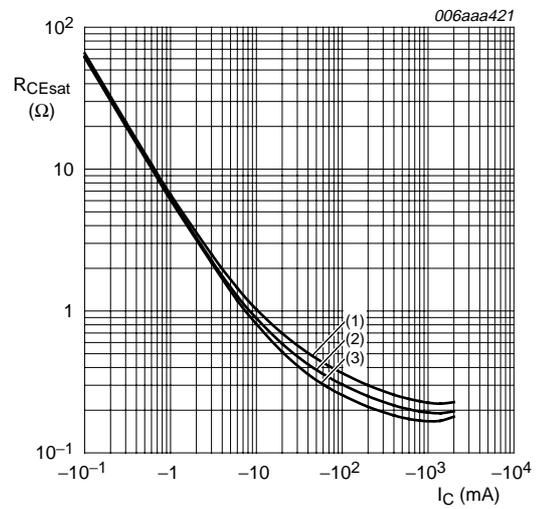
$I_C/I_B = 20$

(1) $T_{amb} = 100\ °C$
(2) $T_{amb} = 25\ °C$
(3) $T_{amb} = -55\ °C$

Fig 10. TR1 (PNP): Collector-emitter saturation resistance as a function of collector current; typical values

006aaa422
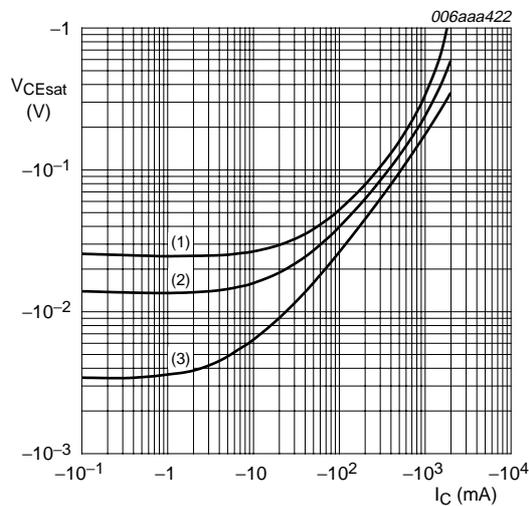
$T_{amb} = 25\ °C$

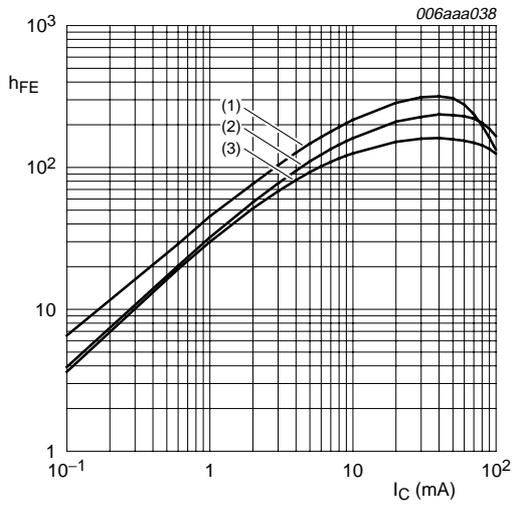(1) $I_C/I_B = 100$
(2) $I_C/I_B = 50$
(3) $I_C/I_B = 10$

Fig 11. TR1 (PNP): Collector-emitter saturation voltage as a function of collector current; typical values

006aaa423
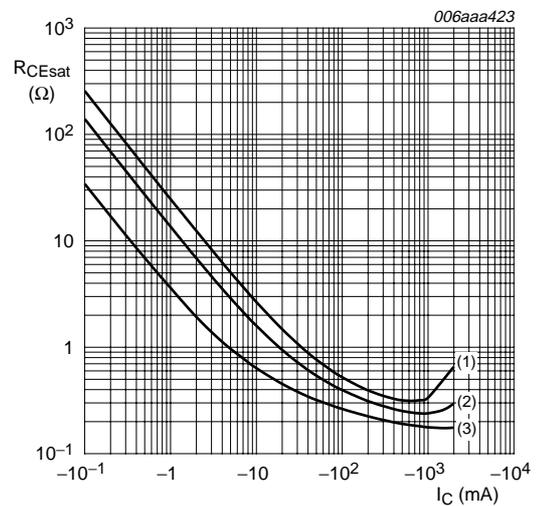
$T_{amb} = 25\ °C$

(1) $I_C/I_B = 100$
(2) $I_C/I_B = 50$
(3) $I_C/I_B = 10$

Fig 12. TR1 (PNP): Collector-emitter saturation resistance as a function of collector current; typical values

006aaa038

V_{CE} = 5 V

(1) T_{amb} = 150 °C

(2) T_{amb} = 25 °C

(3) T_{amb} = −40 °C

Fig 13. TR2 (NPN): DC current gain as a function of collector current; typical values

006aaa039
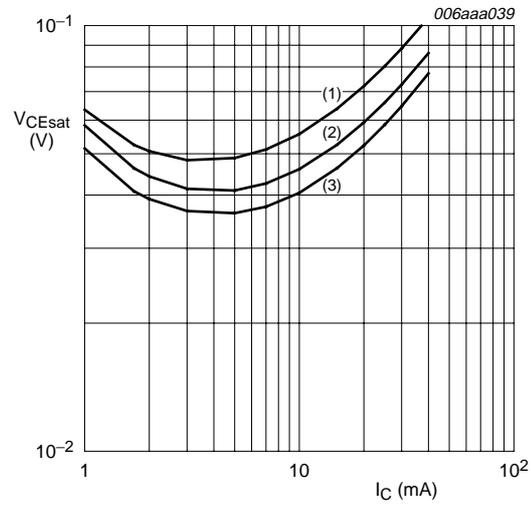
I_C/I_B = 20

(1) T_{amb} = 100 °C

(2) T_{amb} = 25 °C

(3) T_{amb} = −40 °C

Fig 14. TR2 (NPN): Collector-emitter saturation voltage as a function of collector current; typical values

006aaa040
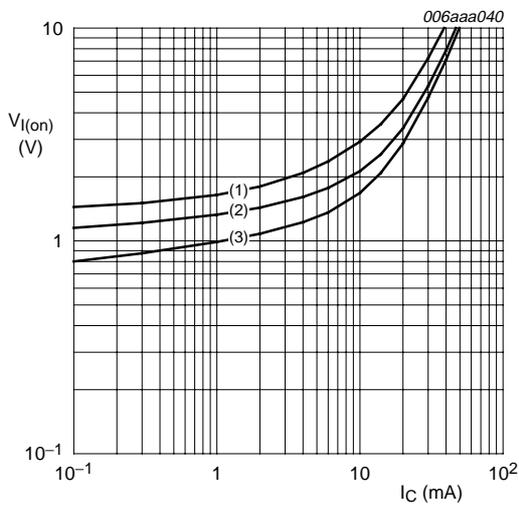
V_{CE} = 0.3 V

(1) T_{amb} = −40 °C

(2) T_{amb} = 25 °C

(3) T_{amb} = 100 °C

Fig 15. TR2 (NPN): On-state input voltage as a function of collector current; typical values

006aaa041
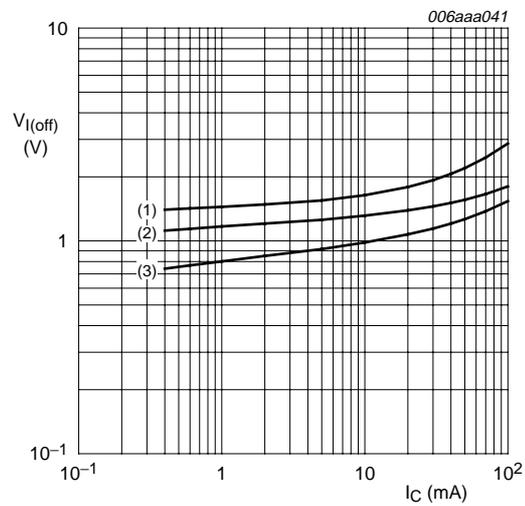
V_{CE} = 5 V
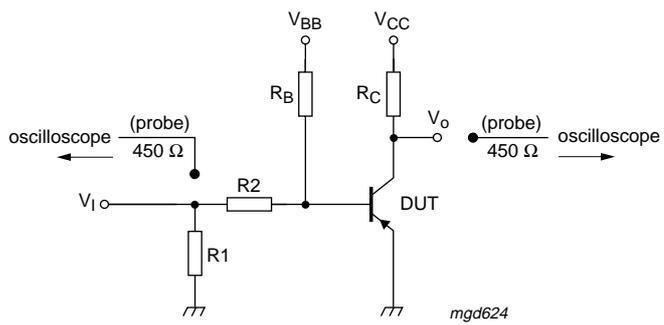
(1) T_{amb} = −40 °C

(2) T_{amb} = 25 °C

(3) T_{amb} = 100 °C

Fig 16. TR2 (NPN): Off-state input voltage as a function of collector current; typical values
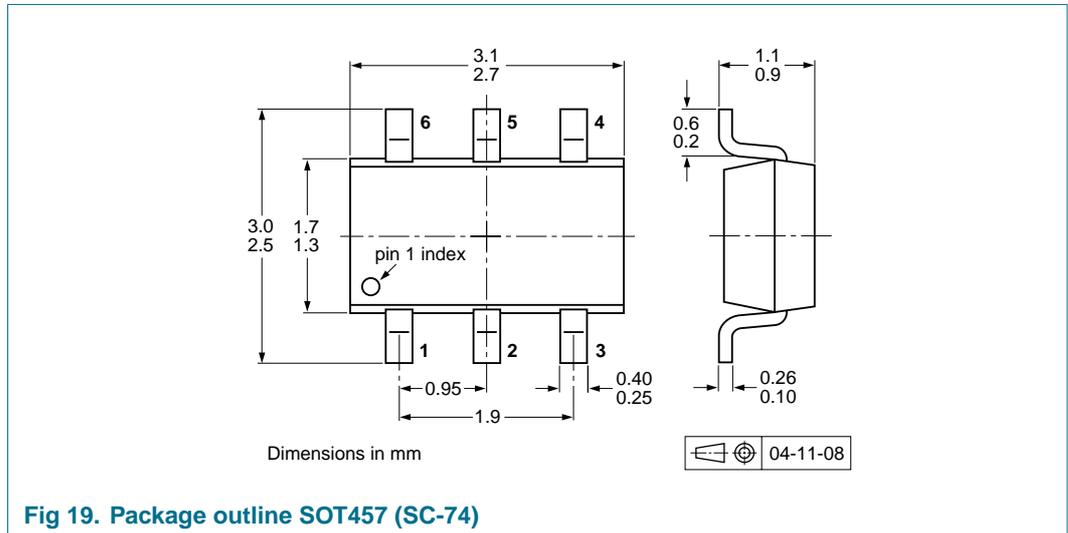
8. Test information
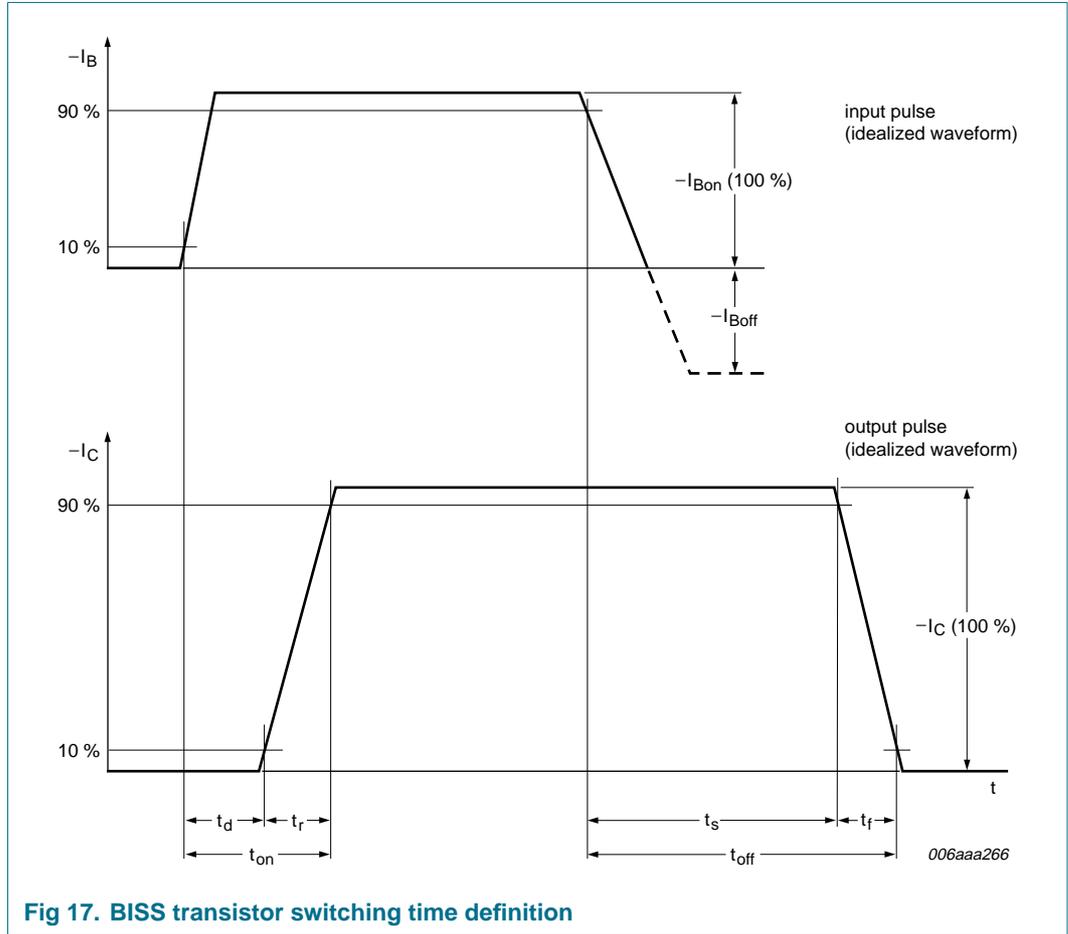
Fig 17. BISS transistor switching time definition

$I_C = -1$ A; $I_{Bon} = -50$ mA; $I_{Boff} = 50$ mA; R1 = open; R2 = 45 Ω; $R_B = 145$ Ω; $R_C = 10$ Ω

Fig 18. Test circuit for switching times

9. Package outline

Dimensions in mm

04-11-08

Fig 19. Package outline SOT457 (SC-74)

10. Packing information

Table 8:   Packing methods
The indicated -xxx are the last three digits of the 12NC ordering code. [1]

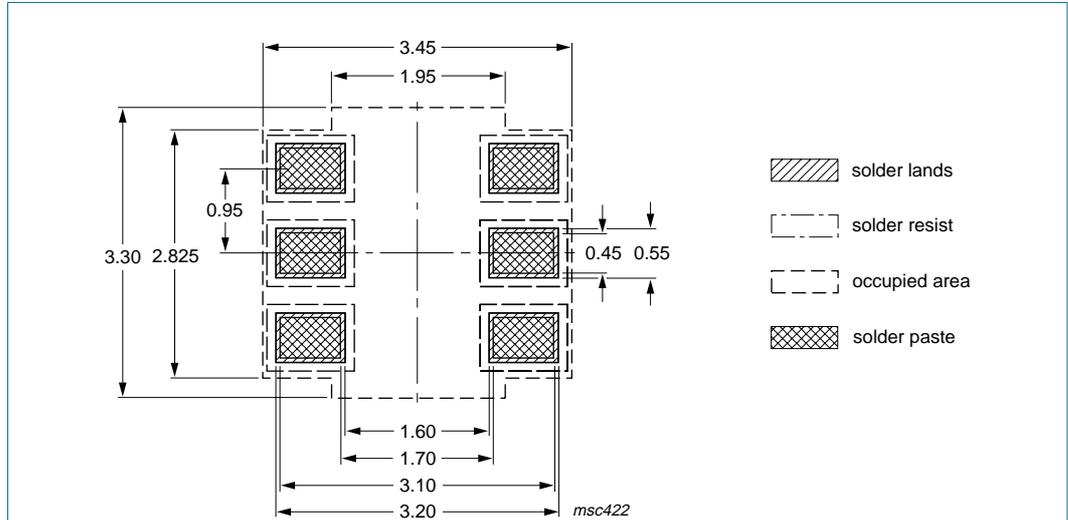| Type number	Package	Description		Packing quantity	
				3000	**10000**
PBLS2004D	SOT457	4 mm pitch, 8 mm tape and reel; T1	[2]	-115	-135
		4 mm pitch, 8 mm tape and reel; T2	[3]	-125	-165

[1]   For further information and the availability of packing methods, see Section 17.
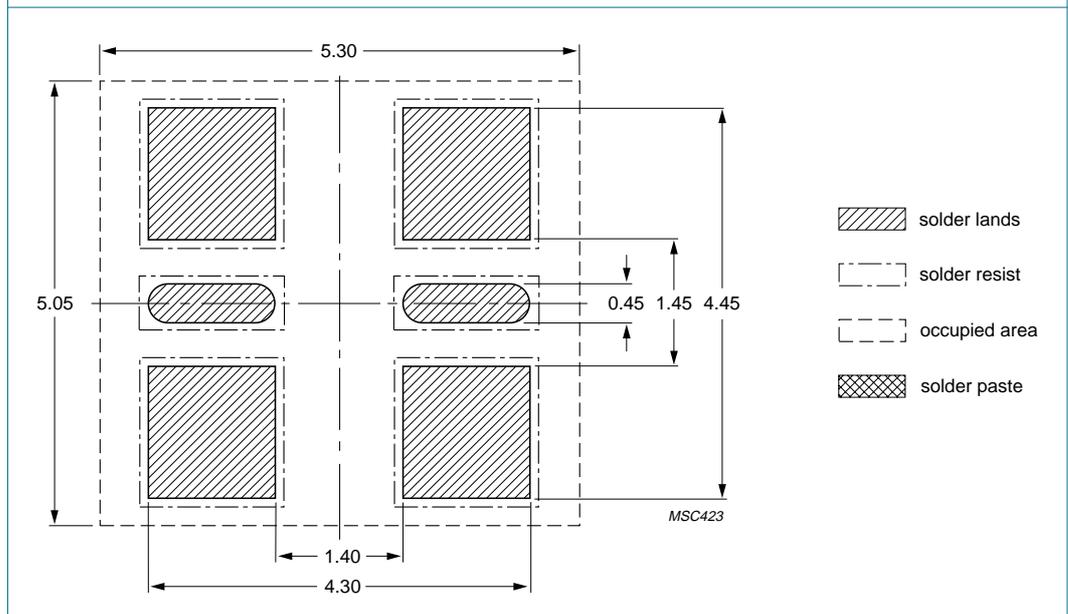
[2]   T1: normal taping

[3]   T2: reverse taping

11. Soldering

Dimensions in mm

Fig 20. Reflow soldering footprint

Dimensions in mm

Fig 21. Wave soldering footprint

12. Revision history

Table 9:   Revision history

Document ID	Release date	Data sheet status	Change notice	Doc. number	Supersedes
PBLS2004D_1	20050623	Product data sheet	-	-	-

13. Data sheet status

Level	Data sheet status [1]	Product status [2] [3]	Definition
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
II	Preliminary data	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product.
III	Product data	Production	This data sheet contains data from the product specification. Philips Semiconductors reserves the right to make changes at any time in order to improve the design, manufacturing and supply. Relevant changes will be communicated via a Customer Product/Process Change Notification (CPCN).

[1] Please consult the most recently issued data sheet before initiating or completing a design.

[2] The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL http://www.semiconductors.philips.com.

[3] For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

14. Definitions

Short-form specification — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

Application information — Applications that are described herein for any of these products are for illustrative purposes only. Philips Semiconductors make no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

15. Disclaimers

Life support — These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips Semiconductors

customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips Semiconductors for any damages resulting from such application.

Right to make changes — Philips Semiconductors reserves the right to make changes in the products - including circuits, standard cells, and/or software - described or contained herein in order to improve design and/or performance. When the product is in full production (status 'Production'), relevant changes will be communicated via a Customer Product/Process Change Notification (CPCN). Philips Semiconductors assumes no responsibility or liability for the use of any of these products, conveys no license or title under any patent, copyright, or mask work right to these products, and makes no representations or warranties that these products are free from patent, copyright, or mask work right infringement, unless otherwise specified.

16. Trademarks

Notice — All referenced brands, product names, service names and trademarks are the property of their respective owners.

17. Contact information

For additional information, please visit: **http://www.semiconductors.philips.com**

For sales office addresses, send an email to: **sales.addresses@www.semiconductors.philips.com**

18. Contents